PATENT APPLICATION

Atty. Docket No.:
Applicant: Hilling Date:

5854-030

Serial No.

10/675,335

Hiromichi Tanimukai and Teruhiko Ohzuchi

September 29, 2003

Group:

2655

INFORMATION DISCLOSURE CITATION FORM PTO-1449 (Modified)

U.S. PATENT DOCUMENTS

Exam <u>Init</u>	Ref	Document <u>Number</u>	Issue <u>Date</u>	<u>Name</u>	Sub Class Class			
FOREIGN PATENT DOCUMENTS								
Exam <u>Init</u>	Ref	Document <u>Number</u>	Publication Date	Country	<u>Name</u>			
VP		2000-003276	Jan. 7, 00	Japan	Akamatsu Junko			
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VP English language abstract of Japanese Publication No. 2000-003276								
VP English language abstract of Japanese Publication No. 05-081012								
Examiner:/Van Pham/								
Date Considered:07/27/2006								



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_VP	English language	English language abstract of Japanese Publication No. 11003219				
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<u>VP</u>	No. 2000207193					

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/Van Pham/ Examiner:

Date Considered: _____07/27/2006

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Sheet 1 of 1

Form PTO-1449 (modified) INFORMATION DISCLOSURE CITATION	Atty. Docket No. 5854-30 (MTM-70-US)	Serial No. 10/675,335
	Applicant: Tanimukai et al	Examiner Wayne R. Young
	Filing Date September 29, 2003	Group 2652

Foreign Patent Documents

Examiner Initial	Document Number	Date	Country	Name	Class
VP	EP0851418A2	07/01/1998	EP	Kabushiki Kaisha Toshiba	G11B 20/00

Examiner /Van Pham/ Date Considered 07/27/2006

^{*}Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.